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An investigation of c-HiPIMS discharges during titanium deposition

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1 **Abstract** 

A modified version of high power impulse magnetron sputtering (HiPIMS) has been

used to deposit titanium films at higher deposition rates than for conventional HiPIMS whilst

maintaining similar pulse voltages and peak currents. This process, named chopped-HiPIMS

(c-HiPIMS) utilises pulses decomposed into several short single pulses instead of single

HiPIMS pulses. Experiments show that manipulating the pulse sequence during c-HiPIMS,

i.e. the  $t_{\mu on}$  and  $t_{\mu off}$  times (explained in the glossary) allows for an increase of the deposition

rate; increases of up to 150 % are reported here for selected conditions. Further, deposition

rates higher than those measured using direct current magnetron sputtering are also shown.

Investigations by optical emission and optical absorption spectroscopy at the substrate show

that the increase of deposition rate is not a consequence of different ion concentrations

arriving at the substrate when changing the micro-pulse-off times of c-HiPIMS. Thus

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